# Power MOSFET 6.9 Amps, 20 Volts

#### N-Channel TSSOP-8

#### **Features**

- New Low Profile TSSOP-8 Package
- Ultra Low R<sub>DS(on)</sub>
- Higher Efficiency Extending Battery Life
- Logic Level Gate Drive
- Diode Exhibits High Speed, Soft Recovery
- Avalanche Energy Specified
- I<sub>DSS</sub> and V<sub>DS(on)</sub> Specified at Elevated Temperatures
- Pb-Free Package is Available

#### **Applications**

- Power Management in Portable and Battery-Powered Products, i.e.: Computers, Printers, PCMCIA Cards, Cellular and Cordless Phones
- Battery Applications
- NoteBook PC

#### **MAXIMUM RATINGS** (T<sub>C</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>	20	Vdc
Drain-to-Gate Voltage (R <sub>GS</sub> = 1.0 MΩ)	$V_{DGR}$	20	Vdc
Gate-to-Source Voltage - Continuous	V <sub>GS</sub>	±12	Vdc
Thermal Resistance – Single Die Junction-to-Ambient (Note 1) Total Power Dissipation @ T <sub>A</sub> = 25°C Continuous Drain Current @ T <sub>A</sub> = 25°C Pulsed Drain Current (Note 4)	R <sub>θJA</sub> P <sub>D</sub> I <sub>D</sub>	62.5 2.0 6.9 24	°C/W W Adc Adc
Thermal Resistance – Single Die Junction-to-Ambient (Note 2) Total Power Dissipation @ T <sub>A</sub> = 25°C Continuous Drain Current @ T <sub>A</sub> = 25°C Continuous Drain Current @ T <sub>A</sub> = 70°C Pulsed Drain Current (Note 4)	R <sub>0JA</sub> P <sub>D</sub> I <sub>D</sub> I <sub>D</sub>	88 1.42 5.8 4.6 20	°C/W W Adc Adc Adc
Thermal Resistance – Single Die Junction-to-Ambient (Note 3) Total Power Dissipation @ T <sub>A</sub> = 25°C Continuous Drain Current @ T <sub>A</sub> = 25°C Continuous Drain Current @ T <sub>A</sub> = 70°C Pulsed Drain Current (Note 4)	R <sub>0JA</sub> P <sub>D</sub> I <sub>D</sub> I <sub>DM</sub>	132 0.94 4.7 3.8 14	°C/W W Adc Adc Adc
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ( $V_{DD} = 20$ Vdc, $V_{GS} = 5.0$ Vdc, Peak $I_L = 5.5$ Apk, $L = 10$ mH, $R_G = 25~\Omega$ )	E <sub>AS</sub>	150	mJ
Maximum Lead Temperature for Soldering Purposes for 10 seconds	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Mounted onto a 2" square FR-4 board
  - (1 in sq, 2 oz Cu 0.06" thick single-sided), t < 10 seconds.
- 2. Mounted onto a 2" square FR-4 board (1 in sq, 2 oz Cu 0.06" thick single-sided), t = ss.
- Minimum FR-4 or G-10 PCB, t = steady state.
   Pulse Test: Pulse Width = 300 μs, Duty Cycle = 2%.

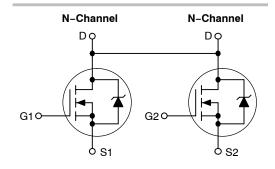


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## 6.9 AMPERES 20 VOLTS

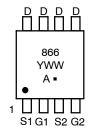
30 m $\Omega$  @ V<sub>GS</sub> = 4.5 V



### MARKING DIAGRAM & PIN ASSIGNMENT



TSSOP-8 CASE 948S PLASTIC



866 = Specific Device Code A = Assembly Location

Y = Year WW = Work Week ■ = Pb-Free Package

#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTQD6866R2	TSSOP-8	4000/Tape & Reel
NTQD6866R2G	TSSOP-8 (Pb-Free)	4000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D

#### **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS				•		•
$\begin{array}{l} \text{Drain-to-Source Breakdown Voltage} \\ \text{(V}_{GS} = 0 \text{ Vdc, I}_D = 250 \ \mu\text{Adc)} \\ \text{Temperature Coefficient (Positive)} \end{array}$	9	V <sub>(BR)DSS</sub>	20 -	_ 18.5	- -	Vdc mV/°C
Zero Gate Voltage Drain Current $ (V_{GS} = 0 \ Vdc, \ V_{DS} = 20 \ Vdc, \ T_J = 25^{\circ}C) $ $ (V_{GS} = 0 \ Vdc, \ V_{DS} = 20 \ Vdc, \ T_J = 100^{\circ}C) $		I <sub>DSS</sub>	- -	- -	1.0 10	μAdc
Gate-Body Leakage Current ( $V_{GS} = \pm 12 \text{ Vdc}$ , $V_{DS} = 0 \text{ Vdc}$ )		I <sub>GSS</sub>	-	-	±100	nAdc
ON CHARACTERISTICS				•		•
Gate Threshold Voltage $(V_{DS} = V_{GS}, I_D = 250 \mu\text{Adc})$ Temperature Coefficient (Negative)		V <sub>GS(th)</sub>	0.6	0.9 -2.7	1.2 -	Vdc mV/°C
Static Drain-to-Source On-State Resistance ( $V_{GS} = 4.5 \text{ Vdc}$ , $I_D = 6.9 \text{ Adc}$ ) ( $V_{GS} = 4.5 \text{ Vdc}$ , $I_D = 5.8 \text{ Adc}$ ) ( $V_{GS} = 2.5 \text{ Vdc}$ , $I_D = 3.5 \text{ Adc}$ ) ( $V_{GS} = 2.5 \text{ Vdc}$ , $I_D = 2.9 \text{ Adc}$ )		R <sub>DS(on)</sub>	- - -	0.026 0.025 0.030 0.030	0.032 0.030 0.038 0.038	Ω
Forward Transconductance $(V_{DS} = 10 \text{ Vdc}, I_D = 5.8 \text{ Adc})$		9FS	-	14	-	Mhos
DYNAMIC CHARACTERISTICS		•		•		•
Input Capacitance		C <sub>iss</sub>	-	875	1400	pF
Output Capacitance	$(V_{DS} = 16 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	C <sub>oss</sub>	-	325	550	
Reverse Transfer Capacitance	,	C <sub>rss</sub>	_	100	175	
SWITCHING CHARACTERISTICS (	(Note 5)					
Turn-On Delay Time		t <sub>d(on)</sub>	_	10	18	ns
Rise Time	(V <sub>DD</sub> = 16 Vdc, I <sub>D</sub> = 5.8 Adc,	t <sub>r</sub>	_	45	80	
Turn-Off Delay Time	$V_{GS} = 4.5 \text{ Vdc}, R_G = 6.0 \Omega$	t <sub>d(off)</sub>	-	40	75	
Fall Time		t <sub>f</sub>	-	90	150	
Turn-On Delay Time		t <sub>d(on)</sub>	-	8.0	-	
Rise Time	(V <sub>DD</sub> = 16 Vdc, I <sub>D</sub> = 5.8 Adc,	t <sub>r</sub>	-	45	-	
Turn-Off Delay Time	$V_{GS} = 4.5 \text{ Vdc}, R_G = 3.0 \Omega$	t <sub>d(off)</sub>	-	35	-	
Fall Time		t <sub>f</sub>	-	75	-	
Gate Charge		Q <sub>tot</sub>	-	13	22	nC
	$(V_{DS} = 16 \text{ Vdc}, V_{GS} = 4.5 \text{ Vdc}, I_{D} = 5.8 \text{ Adc})$	Q <sub>gs</sub>	-	1.8	-	]
		Q <sub>gd</sub>	-	4.5	-	
BODY-DRAIN DIODE RATINGS						
Forward On-Voltage	$(I_S = 5.8 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = 5.8 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 100^{\circ}\text{C})$	V <sub>SD</sub>	- -	0.85 0.75	1.0 -	Vdc
Reverse Recovery Time	$(I_S = 5.8 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, V_{DS} = 20 \text{ Vdc}$	t <sub>rr</sub>	-	23	-	ns
		t <sub>b</sub>	-	11	-	
	$dI_{S}/dt = 100 A/\mu s)$	ta	_	12	-	1

<sup>5.</sup> Switching characteristics are independent of operating junction temperature.

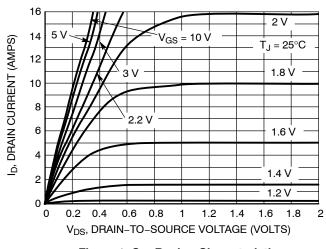


Figure 1. On-Region Characteristics

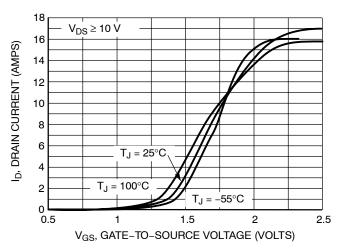


Figure 2. Transfer Characteristics

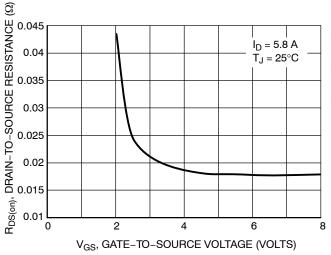


Figure 3. On-Resistance versus Gate-to-Source Voltage

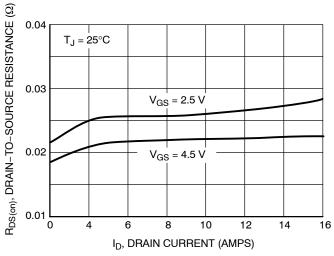


Figure 4. On-Resistance versus Drain Current and Gate Voltage

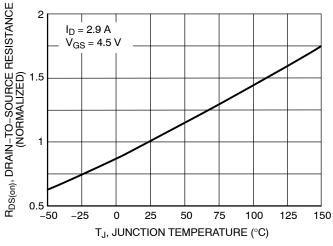


Figure 5. On–Resistance Variation with Temperature

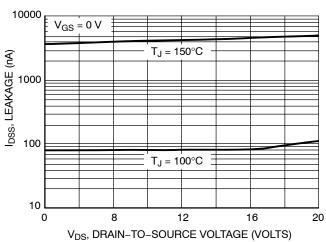


Figure 6. Drain-to-Source Leakage Current versus Voltage

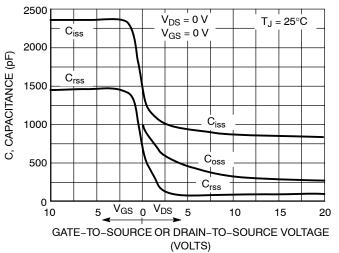


Figure 7. Capacitance Variation

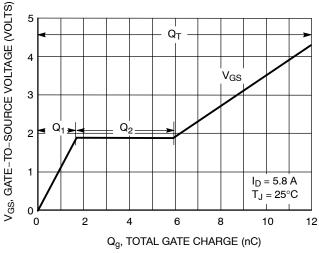


Figure 8. Gate-to-Source Voltage versus Total Charge

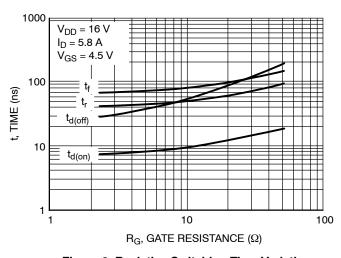


Figure 9. Resistive Switching Time Variation versus Gate Resistance

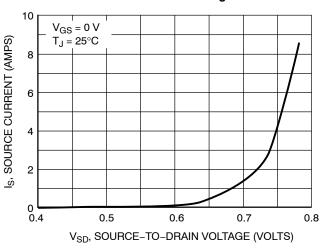


Figure 10. Diode Forward Voltage versus Current

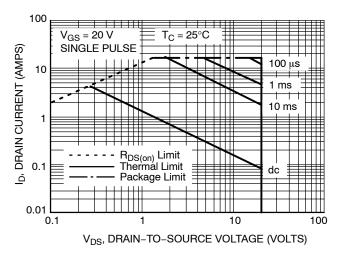


Figure 11. Maximum Rated Forward Biased Safe Operating Area

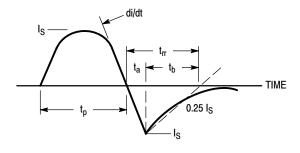


Figure 12. Diode Reverse Recovery Waveform

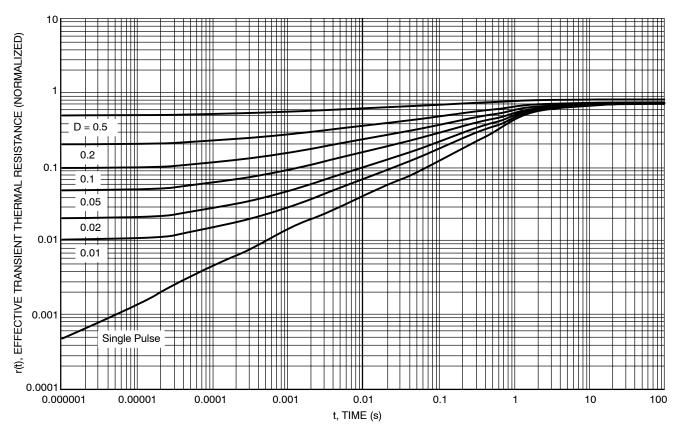
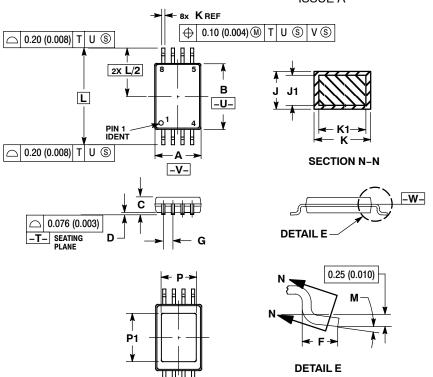


Figure 13. Thermal Response

#### **PACKAGE DIMENSIONS**

#### TSSOP-8 CASE 948S-01 **ISSUE A**



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- ANSI Y14.5M, 1982.

  2. CONTROLLING DIMENSION: MILLIMETER.

  3. DIMENSION A DOES NOT INCLUDE MOLD FLASH. PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.

  4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.

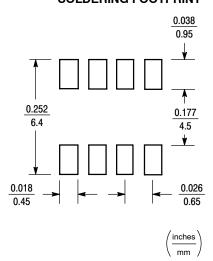
  5. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.

  6. DIMENSION A AND B ARE TO BE

- DIMENSION A AND B ARE TO BE
   DETERMINED AT DATUM PLANE -W-.

	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	2.90	3.10	0.114	0.122	
В	4.30	4.50	0.169	0.177	
С		1.10		0.043	
D	0.05	0.15	0.002	0.006	
F	0.50	0.70	0.020	0.028	
G	0.65 BSC		0.026 BSC		
J	0.09	0.20	0.004	0.008	
J1	0.09	0.16	0.004	0.006	
K	0.19	0.30	0.007	0.012	
K1	0.19	0.25	0.007	0.010	
L	6.40			52 BSC	
M	0°	8°	0°	8 °	
Р		2.20		0.087	
P1		3.20		0.126	

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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